2N7002PW

60 V, 310 mA N-channel Trench MOSFET Rev. 02 — 29 July 2010

Product data sheet

Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a very small SOT323 (SC-70) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- AEC-Q101 qualified
- Logic-level compatible

- Trench MOSFET technology
- Very fast switching

1.3 Applications

- High-speed line driver
- Low-side loadswitch

- Relay driver
- Switching circuits

1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|-------------------|--|---|-----|-----|-----|-----|------|
| V_{DS} | drain-source voltage | T _{amb} = 25 °C | | - | - | 60 | V |
| V_{GS} | gate-source voltage | | | -20 | - | 20 | V |
| I _D | drain current | V_{GS} = 10 V; T_{amb} = 25 °C | [1] | - | - | 310 | mA |
| Static char | racteristics | | | | | | |
| R _{DSon} | drain-source on-state resistance | V_{GS} = 10 V; I_D = 500 mA; T_j = 25 °C; t_p ≤ 300 µs; pulsed; δ ≤ 0.01 | | - | 1 | 1.6 | Ω |

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².



60 V, 310 mA N-channel Trench MOSFET

2. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------|--------------------|----------------|
| 1 | G | gate | | |
| 2 | S | source | 3 | D |
| 3 | D | drain | 1 | mbb076 S |

3. Ordering information

Table 3. Ordering information

| Type number | Package | | |
|-------------|---------|--|---------|
| | Name | Description | Version |
| 2N7002PW | SC-70 | plastic surface-mounted package; 3 leads | SOT323 |

4. Marking

Table 4. Marking codes

| Type number | Marking code ^[1] |
|-------------|-----------------------------|
| 2N7002PW | X8% |

^[1] % = -: made in Hong Kong; % = p: made in Hong Kong; % = t: made in Malaysia; % = W: made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|------------------|-------------------------|---|------------|-----|-----|------|
| V_{DS} | drain-source voltage | T _{amb} = 25 °C | | - | 60 | V |
| V_{GS} | gate-source voltage | | | -20 | 20 | V |
| I _D | drain current | V_{GS} = 10 V; T_{amb} = 25 °C | <u>[1]</u> | - | 310 | mΑ |
| | | V _{GS} = 10 V; T _{amb} = 100 °C | <u>[1]</u> | - | 240 | mA |
| I_{DM} | peak drain current | $T_{amb} = 25 ^{\circ}C$; single pulse; $t_p \le 10 \mu s$ | | - | 1.2 | Α |
| P _{tot} | total power dissipation | T _{amb} = 25 °C | [2] | - | 260 | mW |
| | | | [1] | - | 310 | mW |
| | | T _{sp} = 25 °C | | - | 830 | mW |
| Tj | junction temperature | | | - | 150 | °C |
| T _{amb} | ambient temperature | | | -55 | 150 | °C |
| T _{stg} | storage temperature | | | -65 | 150 | °C |
| Source-dra | nin diode | | | | | |
| Is | source current | T _{amb} = 25 °C | [1] | - | 310 | mA |

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².

2N7002PW All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2010. All rights reserved.

60 V, 310 mA N-channel Trench MOSFET

[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

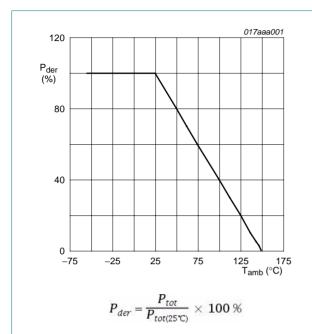


Fig 1. Normalized total power dissipation as a function of ambient temperature

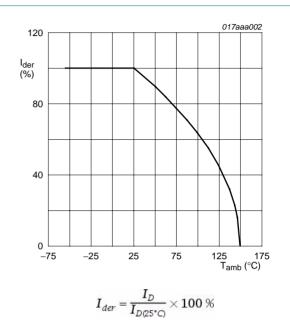
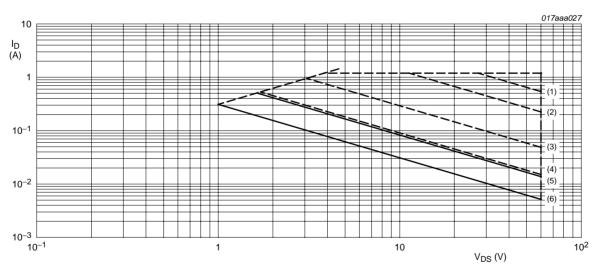


Fig 2. Normalized continuous drain current as a function of ambient temperature



I_{DM} = single pulse

(1) $t_p = 100 \mu s$

(2) $t_p = 1 \text{ ms}$

(3) $t_p = 10 \text{ ms}$

(4) $t_p = 100 \text{ ms}$

(5) DC; $T_{sp} = 25 \, ^{\circ}\text{C}$

(6) DC; $T_{amb} = 25$ °C; drain mounting pad 1 cm²

Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

60 V, 310 mA N-channel Trench MOSFET

6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
|-----------------------|--|------------|------------|-----|-----|-----|------|
| $R_{th(j-a)}$ | thermal resistance | | <u>[1]</u> | - | 415 | 480 | K/W |
| | from junction to ambient | | [2] | - | 350 | 400 | K/W |
| R _{th(j-sp)} | thermal resistance from junction to solder point | | | - | - | 150 | K/W |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm².

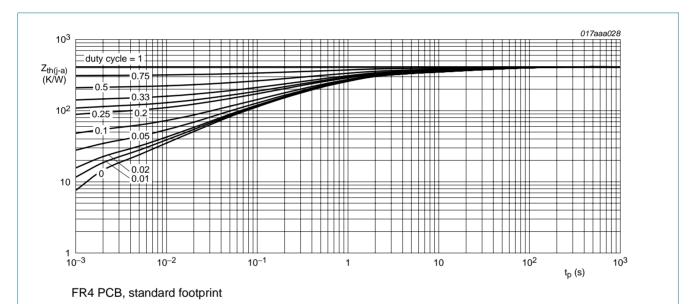


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

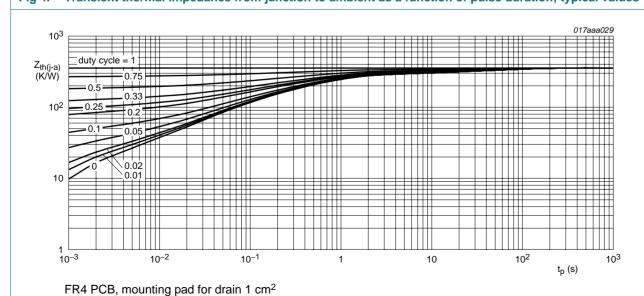


Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

2N7002P

All information provided in this document is subject to legal disclaimers.

© NXP B.V. 2010. All rights reserved.

60 V, 310 mA N-channel Trench MOSFET

7. Characteristics

Table 7. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|-----------------------------------|---|------|------|-----|------|
| Static chara | cteristics | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 10 \mu A; V_{GS} = 0 V; T_j = 25 °C$ | 60 | - | - | V |
| V_{GSth} | gate-source threshold voltage | $I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$ | 1.1 | 1.75 | 2.4 | V |
| I _{DSS} | drain leakage current | $V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | - | 1 | μΑ |
| | | $V_{DS} = 60 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$ | - | - | 10 | μΑ |
| I _{GSS} | gate leakage current | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | - | 100 | nΑ |
| | | $V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | - | 100 | nΑ |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 5 \text{ V}; I_D = 50 \text{ mA}; \text{ pulsed};$ $t_p \le 300 \mu\text{s}; \delta \le 0.01 ; T_j = 25 ^{\circ}\text{C}$ | - | 1.3 | 2 | Ω |
| | | V_{GS} = 10 V; I_{D} = 500 mA; pulsed; $t_{p} \le$ 300 µs; $\delta \le$ 0.01 ; T_{j} = 25 °C | - | 1 | 1.6 | Ω |
| 9 _{fs} | forward transconductance | $V_{DS} = 10 \text{ V}; I_D = 200 \text{ mA}; \text{ pulsed};$ $t_p \le 300 \mu\text{s}; \delta \le 0.01 ; T_j = 25 ^{\circ}\text{C}$ | - | 400 | - | mS |
| Dynamic ch | aracteristics | | | | | |
| Q _{G(tot)} | total gate charge | $I_D = 300 \text{ mA}; V_{DS} = 30 \text{ V}; V_{GS} = 4.5 \text{ V};$ | - | 0.6 | 8.0 | nC |
| Q_{GS} | gate-source charge | $T_j = 25 ^{\circ}\text{C}$ | - | 0.2 | - | nC |
| Q_{GD} | gate-drain charge | | - | 0.2 | - | nC |
| C _{iss} | input capacitance | $V_{GS} = 0 \text{ V}; V_{DS} = 10 \text{ V}; f = 1 \text{ MHz};$ | - | 30 | 50 | pF |
| C _{oss} | output capacitance | $T_j = 25 ^{\circ}\text{C}$ | - | 7 | - | pF |
| C _{rss} | reverse transfer capacitance | | - | 4 | - | pF |
| t _{d(on)} | turn-on delay time | $V_{DS} = 50 \text{ V}; R_L = 250 \Omega; V_{GS} = 10 \text{ V};$ | - | 3 | 6 | ns |
| t _r | rise time | $R_{G(ext)} = 6 \Omega; T_j = 25 °C$ | - | 4 | - | ns |
| t _{d(off)} | turn-off delay time | | - | 10 | 20 | ns |
| t _f | fall time | | - | 5 | - | ns |
| Source-drai | n diode | | | | | |
| V_{SD} | source-drain voltage | $I_S = 115 \text{ mA}; V_{GS} = 0 \text{ V}; T_i = 25 \text{ °C}$ | 0.47 | 0.75 | 1.1 | V |

60 V, 310 mA N-channel Trench MOSFET

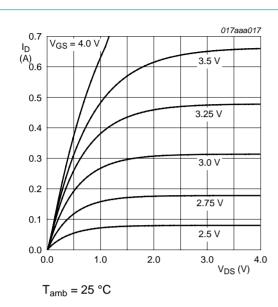
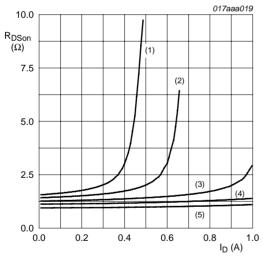


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_{amb} = 25 \, ^{\circ}C$

(1) $V_{GS} = 3.25 \text{ V}$

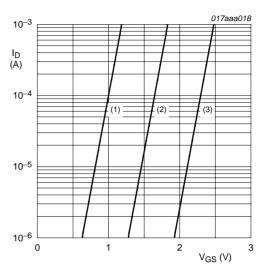
(2) $V_{GS} = 3.5 \text{ V}$

(3) $V_{GS} = 4 V$

(4) $V_{GS} = 5 \text{ V}$

 $(5) V_{GS} = 10 V$

Fig 8. Drain-source on-state resistance as a function of drain current; typical values



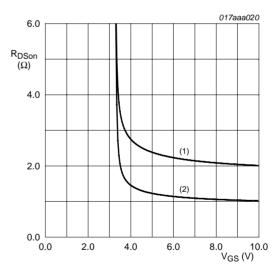
 $T_{amb} = 25 \, ^{\circ}C; \, V_{DS} = 5 \, V$

(1) minimum values

(2) typical values

(3) maximum values

Fig 7. Sub-threshold drain current as a function of gate-source voltage



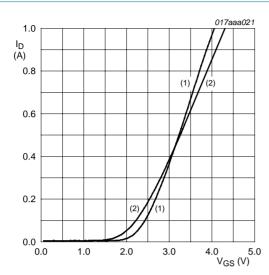
 $I_D = 500 \text{ mA}$

(1) $T_{amb} = 150 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

60 V, 310 mA N-channel Trench MOSFET

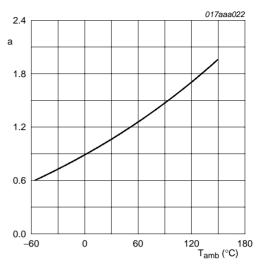


 $V_{DS} > I_D \times R_{DSon}$

(1) $T_{amb} = 25 \, ^{\circ}C$

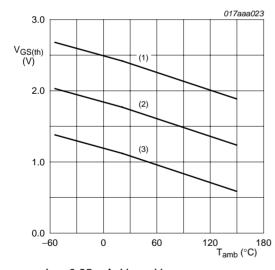
(2) $T_{amb} = 150 \, ^{\circ}C$

Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$

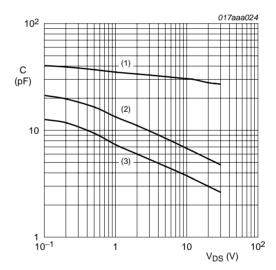
Fig 11. Normalized drain-source on-state resistance as a function of ambient temperature; typical values



 $I_D = 0.25 \text{ mA}; V_{DS} = V_{GS}$

- (1) maximum values
- (2) typical values
- (3) minimum values

Fig 12. Gate-source threshold voltage as a function of ambient temperature

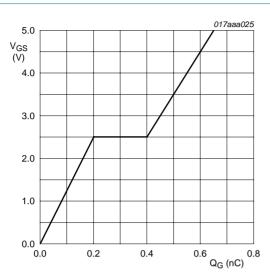


 $f = 1 MHz; V_{GS} = 0 V$

- (1) C_{iss}
- (2) Coss
- (3) C_{rss}

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

60 V, 310 mA N-channel Trench MOSFET



 I_D = 300 mA; V_{DS} = 30 V; T_{amb} = 25 °C

Fig 14. Gate-source voltage as a function of gate charge; typical values

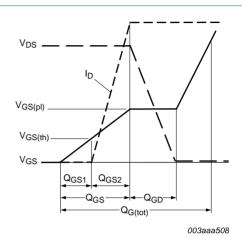
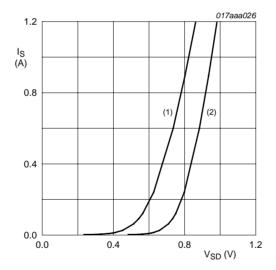


Fig 15. Gate charge waveform definitions



 $V_{GS} = 0 V$

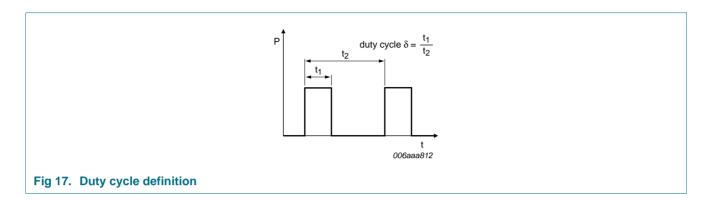
(1) $T_{amb} = 150 \, ^{\circ}C$

(2) $T_{amb} = 25 \, ^{\circ}C$

Fig 16. Source current as a function of source-drain voltage; typical values

60 V, 310 mA N-channel Trench MOSFET

8. Test information



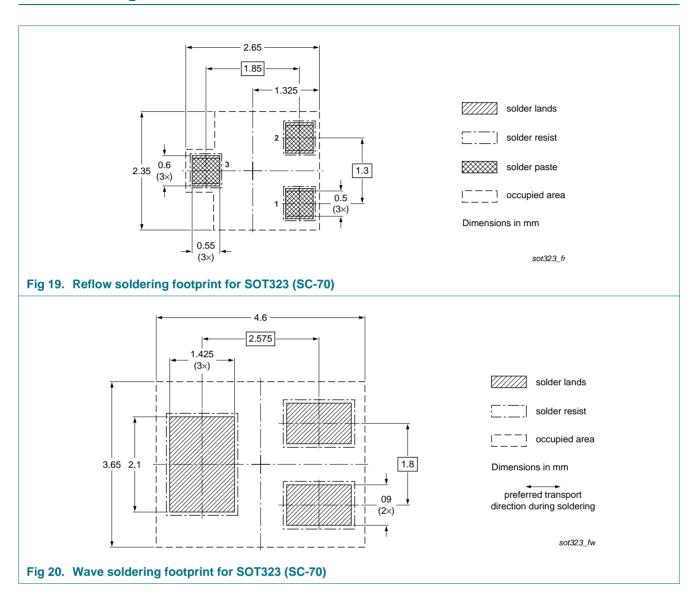
9. Package outline

Plastic surface-mounted package; 3 leads **SOT323** В Α Х = v M A Q **←** | w (M) B е detail X 2 mm scale **DIMENSIONS** (mm are the original dimensions) UNIT D Ε Q С bp е ΗE Lp w max 0.4 1.1 0.25 2.2 1.35 0.45 0.23 0.2 mm 1.3 0.65 0.2 8.0 0.10 1.15 REFERENCES EUROPEAN OUTLINE **ISSUE DATE** PROJECTION **VERSION** IEC **JEDEC** JEITA 04-11-04 SOT323 SC-70 06-03-16

Fig 18. Package outline SOT323 (SC-70)

60 V, 310 mA N-channel Trench MOSFET

10. Soldering



60 V, 310 mA N-channel Trench MOSFET

11. Revision history

Table 8. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|----------------|-------------------------------------|------------------------------|--------------------------|------------|
| 2N7002PW v.2 | 20100729 | Product data sheet | - | 2N7002PW_1 |
| Modifications: | Correction of t | hermal values. | | |
| | Correction of v | arious characteristics value | s including related grap | hs. |
| 2N7002PW_1 | 20100422 | Product data sheet | - | - |

60 V, 310 mA N-channel Trench MOSFET

12. Legal information

12.1 Data sheet status

| Document status[1][2] | Product status[3] | Definition |
|--------------------------------|-------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

12.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

12.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

2N7002PW

60 V, 310 mA N-channel Trench MOSFET

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from national authorities.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

12.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

Adelante, Bitport, Bitsound, CoolFlux, CoReUse, DESFire, EZ-HV, FabKey, GreenChip, HiPerSmart, HITAG, I²C-bus logo, ICODE, I-CODE, ITEC, Labelution, MIFARE, MIFARE Plus, MIFARE Ultralight, MoReUse, QLPAK, Silicon Tuner, SiliconMAX, SmartXA, STARplug, TOPFET, TrenchMOS, TriMedia and UCODE — are trademarks of NXP B.V.

HD Radio and **HD Radio** logo — are trademarks of iBiquity Digital Corporation.

13. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

Product data sheet

60 V, 310 mA N-channel Trench MOSFET

14. Contents

| 1 | Product profile |
|------|--------------------------|
| 1.1 | General description |
| 1.2 | Features and benefits |
| 1.3 | Applications |
| 1.4 | Quick reference data1 |
| 2 | Pinning information |
| 3 | Ordering information |
| 4 | Marking |
| 5 | Limiting values |
| 6 | Thermal characteristics4 |
| 7 | Characteristics |
| 8 | Test information |
| 9 | Package outline10 |
| 10 | Soldering11 |
| 11 | Revision history12 |
| 12 | Legal information13 |
| 12.1 | Data sheet status |
| 12.2 | Definitions13 |
| 12.3 | Disclaimers |
| 12.4 | Trademarks14 |
| 13 | Contact information14 |

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

Date of release: 29 July 2010 Document identifier: 2N7002PW

AMEYA360 Components Supply Platform

Authorized Distribution Brand:

























Website:

Welcome to visit www.ameya360.com

Contact Us:

> Address:

401 Building No.5, JiuGe Business Center, Lane 2301, Yishan Rd Minhang District, Shanghai , China

> Sales:

Direct +86 (21) 6401-6692

Email amall@ameya360.com

QQ 800077892

Skype ameyasales1 ameyasales2

Customer Service :

Email service@ameya360.com

Partnership :

Tel +86 (21) 64016692-8333

Email mkt@ameya360.com